

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/602,551	MAKOWSKI ET AL.	
Examiner Thuy Dao		Art Unit 2192		Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2008/0022259 A1	01-2008	MacKlem et al.	717/113
*	B US-7,631,295 B2	12-2009	Makowski et al.	717/113
*	C US-2005/0155014 A1	07-2005	Andrade et al.	717/105
*	D US-7,761,846 B2	07-2010	Hayles, Timothy J.	717/109
*	E US-7,216,334 B2	05-2007	Kodosky et al.	717/109
*	F US-6,763,515 B1	07-2004	Vazquez et al.	717/109
*	G US-7,975,233 B2	07-2011	Macklem et al.	715/763
*	H US-7,937,665 B1	05-2011	Vazquez et al.	715/763
*	I US-6,064,409 A	05-2000	Thomsen et al.	715/700
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Resendez et al., Labview programming for internet-based measurements, April 2003, pages, 79-85, < http://delivery.acm.org/10.1145/770000/767613/p79-resendez.pdf >.
V	National Instruments Inc., Polymorphic Units in LabVIEW, July 2000, 8 pages, < http://mp.ustu.ru/Users/Kalinin/Files/LabView/National%20Instruments6.0/polyunit.pdf >.
W	Bitter et al., Object-Oriented Programming in LabVIEW, 2001, 45 pages, < http://www.physics.utah.edu/~jui/3620-6620/supp/LV_Adv_Prog/2049ch10.pdf >.
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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